

**Notice of References Cited**

Application/Control No.

10/772,315

Applicant(s)/Patent Under  
Reexamination  
YOON ET AL.

Examiner

MARIA VERONICA D. EWALD

Art Unit

1791

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,923,667	05-1990	Sayer, Matthew E.	264/572
*	B	US-6,422,857	07-2002	Wright et al.	425/549
	C	US-			
	D	US-			
	E	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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